# Application/Control No. O9/528,964 Examiner John R Hardee Applicant(s)/Patent Under Reexamination BIVENS ET AL. Art Unit Page 1 of 1

# Notice of References Cited

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			· Ac
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